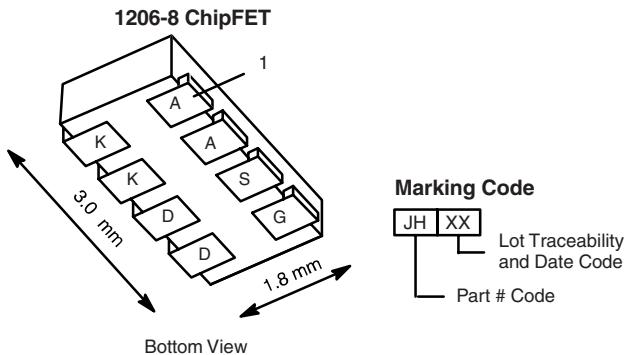




P-Channel 20-V (D-S) MOSFET with Schottky Diode

MOSFET PRODUCT SUMMARY			
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)
- 20	0.105 at V _{GS} = - 4.5 V	- 4 ^a	4.7 nC
	0.143 at V _{GS} = - 2.5 V	- 3.8	
	0.188 at V _{GS} = - 1.8 V	- 3	

SCHOTTKY PRODUCT SUMMARY		
V _{KA} (V)	V _f (V) Diode Forward Voltage	I _F (A)
20	0.46 at 0.5 A	1



FEATURES

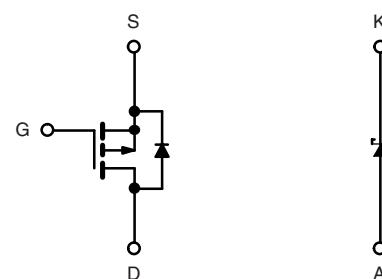
- LITTLE FOOT® Plus Schottky Power MOSFET



RoHS
COMPLIANT

APPLICATIONS

- Charging Switch for Portable Devices
 - With Integrated Low V_f Trench Schottky Diode



Ordering Information: Si5853DDC-T1-E3 (Lead (Pb)-free)

P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted				
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage (MOSFET)	V _{DS}	- 20	V	
Reverse Voltage (Schottky)	V _{KA}	20		
Gate-Source Voltage (MOSFET)	V _{GS}	± 8		
Continuous Drain Current (T _J = 150 °C) (MOSFET)	T _C = 25 °C	I _D		
	T _C = 70 °C			
	T _A = 25 °C			
	T _A = 70 °C			
Pulsed Drain Current (MOSFET)	I _{DM}	- 10	A	
Continuous Source Current (MOSFET Diode Conduction)	T _C = 25 °C	I _S		
	T _A = 25 °C	- 2.6		
Average Forward Current (Schottky)	I _F	1		
Pulsed Forward Current (Schottky)	I _{FM}	3		
Maximum Power Dissipation (MOSFET)	T _C = 25 °C	P _D	W	
	T _C = 70 °C			
	T _A = 25 °C			
	T _A = 70 °C			
Maximum Power Dissipation (Schottky)	T _C = 25 °C			
	T _C = 70 °C			
	T _A = 25 °C			
	T _A = 70 °C			
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendation (Peak Temperature) ^{d, e}		260		

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient (MOSFET) ^{b, c, f}	R _{thJA}	77	95	°C/W
Maximum Junction-to-Foot (Drain) (MOSFET)	R _{thJF}	33	40	
Maximum Junction-to-Ambient (Schottky) ^{b, c, g}	R _{thJA}	85	105	
Maximum Junction-to-Foot (Drain) (Schottky)	R _{thJF}	40	50	

Notes:

- a. Package limited.
- b. Surface Mounted on FR4 board.
- c. t ≤ 5 s.
- d. See Solder Profile (<http://www.vishay.com/doc?73257>). The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions for MOSFETs is 130 °C/W.
- g. Maximum under Steady State conditions for Schottky is 125 °C/W.

SPECIFICATIONS T_J = 25 °C, unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 20			V
V _{DS} Temperature Coefficient	ΔV _{DS/TJ}	I _D = - 250 μA		- 13		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)/TJ}			2.4		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 0.4		- 1	V
Gate-Body Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 8 V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 20 V, V _{GS} = 0 V			- 1	μA
		V _{DS} = - 20 V, V _{GS} = 0 V, T _J = 85 °C			- 10	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≤ - 5 V, V _{GS} = - 4.5 V	- 10			A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 2.9 A		0.085	0.105	Ω
		V _{GS} = - 2.5 V, I _D = - 2.5 A		0.117	0.143	
		V _{GS} = - 1.8 V, I _D = - 1.5 A		0.155	0.188	
Forward Transconductance ^a	g _{fs}	V _{DS} = - 10 V, I _D = - 2.9 A		7		S
Dynamic^b						
Input Capacitance	C _{iss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		320		pF
Output Capacitance	C _{oss}			60		
Reverse Transfer Capacitance	C _{rss}			47		
Total Gate Charge	Q _g	V _{DS} = - 10 V, V _{GS} = - 8 V, I _D = - 2.9 A		7.9	12	nC
				4.7	7.1	
Gate-Source Charge	Q _{gs}	V _{DS} = - 10 V, V _{GS} = - 4.5 V, I _D = - 2.9 A		0.65		
Gate-Drain Charge	Q _{gd}			1.35		
Gate Resistance	R _g	f = 1 MHz		6.5		Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = - 10 V, R _L = 4.4 Ω I _D ≈ - 2.3 A, V _{GEN} = - 4.5 V, R _g = 1 Ω		15	25	ns
Rise Time	t _r			17	30	
Turn-Off Delay Time	t _{d(off)}			21	30	
Fall Time	t _f			10	15	
Turn-On Delay Time	t _{d(on)}	V _{DD} = - 10 V, R _L = 4.4 Ω I _D ≈ - 2.3 A, V _{GEN} = - 8 V, R _g = 1 Ω		5	10	
Rise Time	t _r			10	15	
Turn-Off Delay Time	t _{d(off)}			20	30	
Fall Time	t _f			10	15	



New Product

Si5853DDC

Vishay Siliconix

SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25^\circ\text{C}$			- 2.6	A
Pulse Diode Forward Current	I_{SM}				- 10	
Body Diode Voltage	V_{SD}	$I_S = -2.3\text{ A}, V_{GS} = 0\text{ V}$		- 0.85	- 1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = -2.3\text{ A} \frac{dI}{dt} = 100\text{ A}/\mu\text{s} T_J = 25^\circ\text{C}$		15	30	ns
Body Diode Reverse Recovery Charge	Q_{rr}			9	20	nC
Reverse Recovery Fall Time	t_a			10		ns
Reverse Recovery Rise Time	t_b			5		

Notes:

- Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
- Guaranteed by design, not subject to production testing.

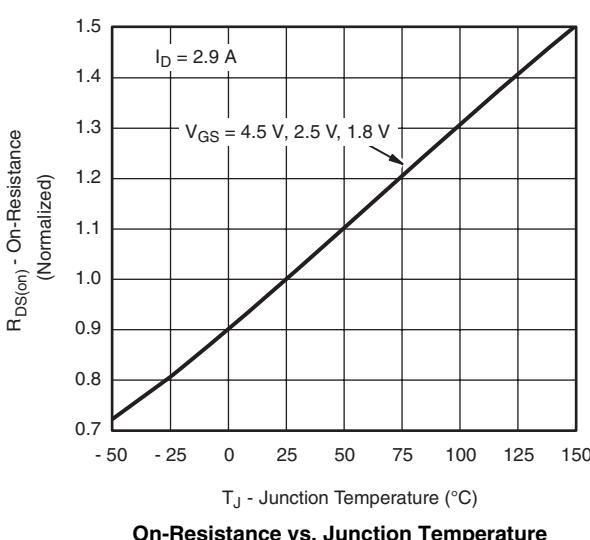
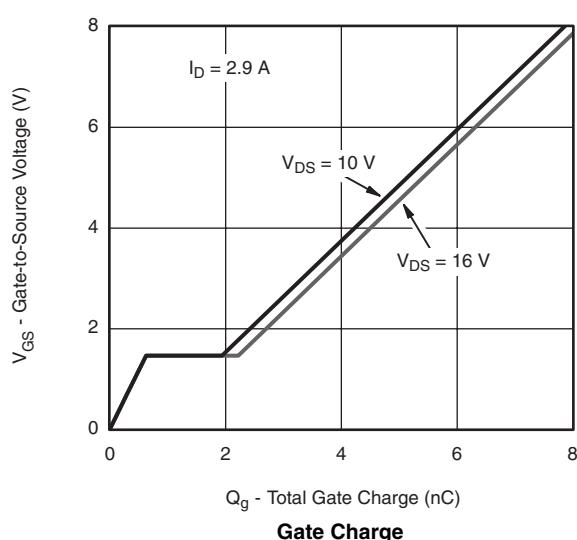
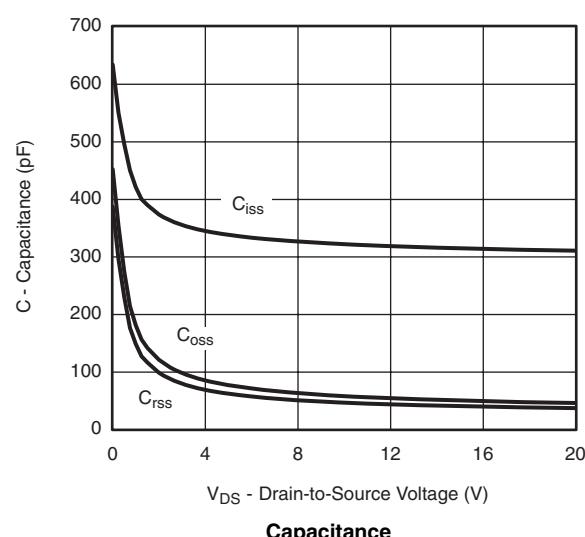
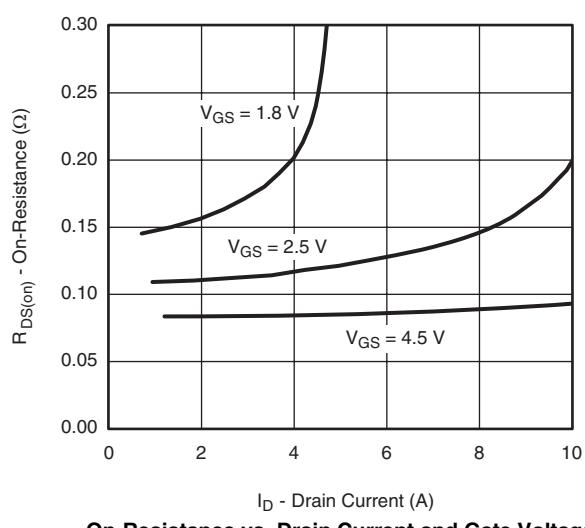
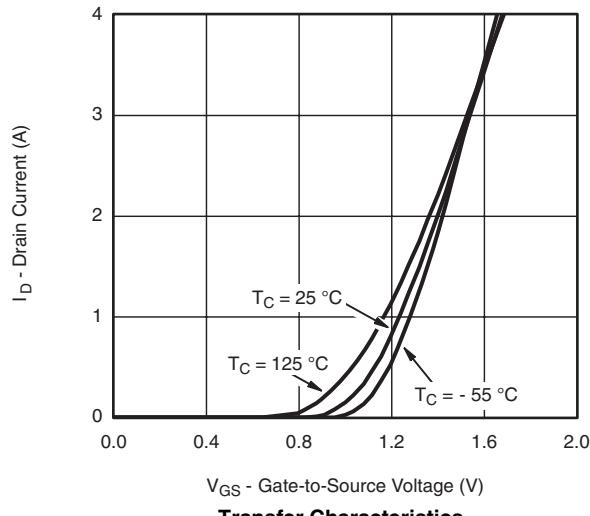
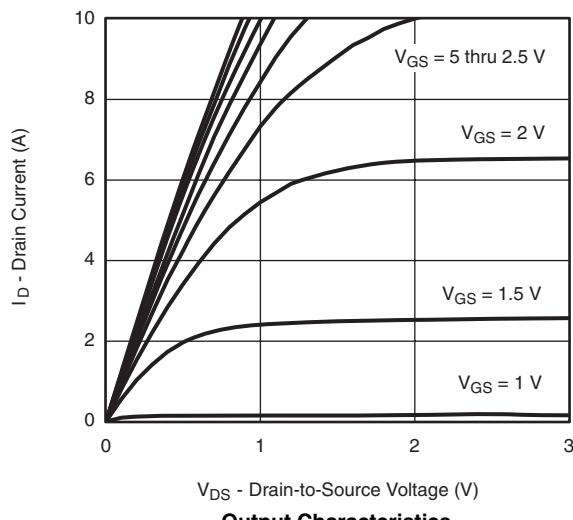
SCHOTTKY SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

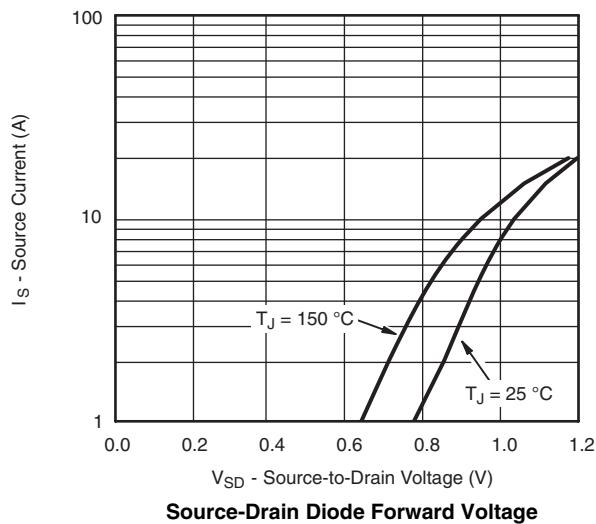
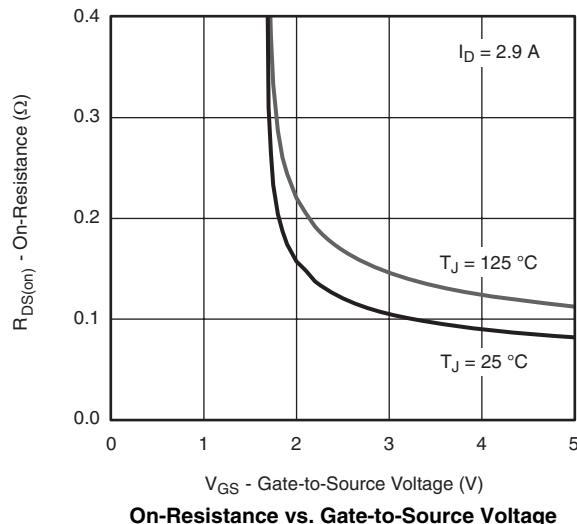
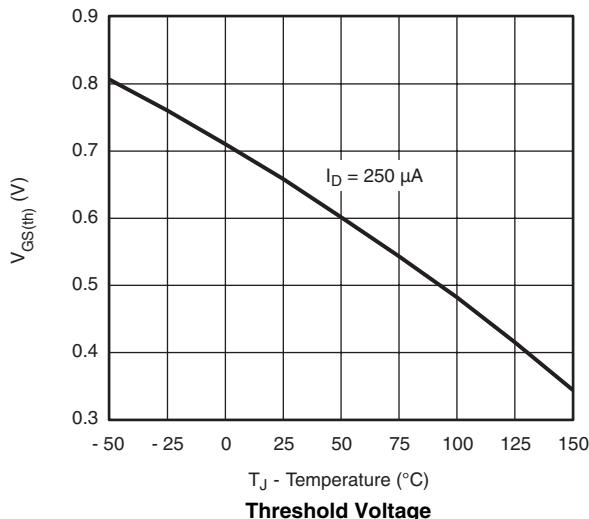
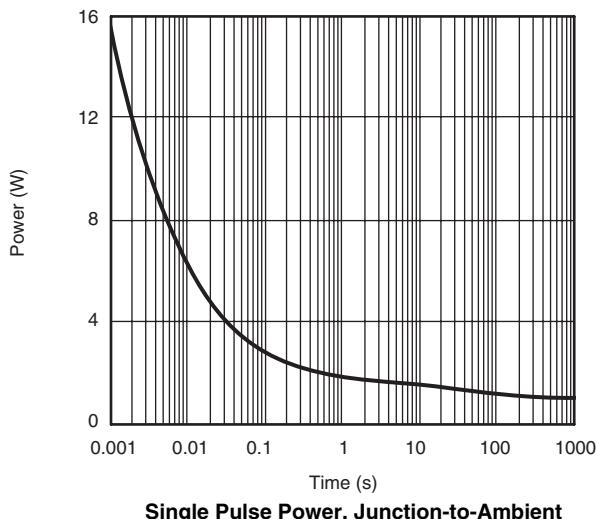
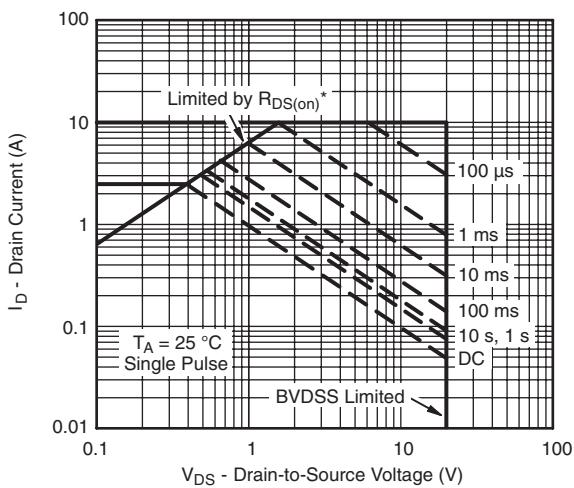
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Forward Voltage Drop	V_F	$I_F = 0.5\text{ A}$		0.381	0.46	V
		$I_F = 1\text{ A}$		0.468	0.560	
		$I_F = 1\text{ A}, T_J = 125^\circ\text{C}$		0.44	0.53	
Maximum Reverse Leakage Current	I_{rm}	$V_r = 5\text{ V}$		0.0081	0.080	mA
		$V_r = 5\text{ V}, T_J = 85^\circ\text{C}$		0.4	4	
		$V_r = 5\text{ V}, T_J = 125^\circ\text{C}$		2.8	28	
		$V_r = 20\text{ V}$		0.0093	0.09	
		$V_r = 20\text{ V}, T_J = 85^\circ\text{C}$		0.45	4.5	
		$V_r = 20\text{ V}, T_J = 125^\circ\text{C}$		3.2	32	
Junction Capacitance	C_T	$V_r = 10\text{ V}$		30		pF

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Si5853DDC

Vishay Siliconix

**MOSFET TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

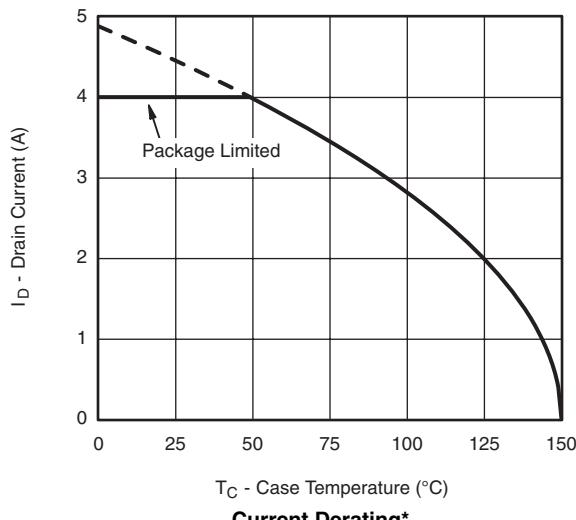
**MOSFET TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted**Source-Drain Diode Forward Voltage****On-Resistance vs. Gate-to-Source Voltage****Threshold Voltage****Single Pulse Power, Junction-to-Ambient****Safe Operating Area, Junction-to-Ambient**

Si5853DDC

Vishay Siliconix

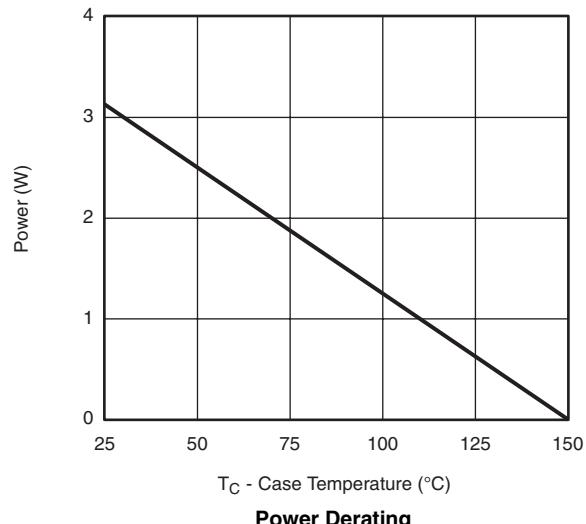


MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

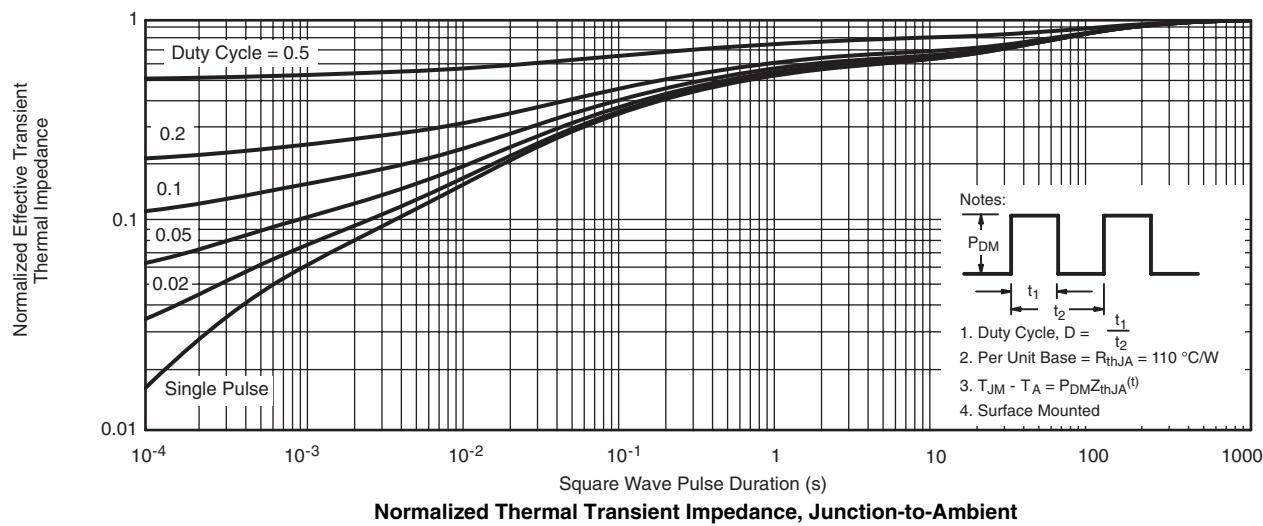
Current Derating*



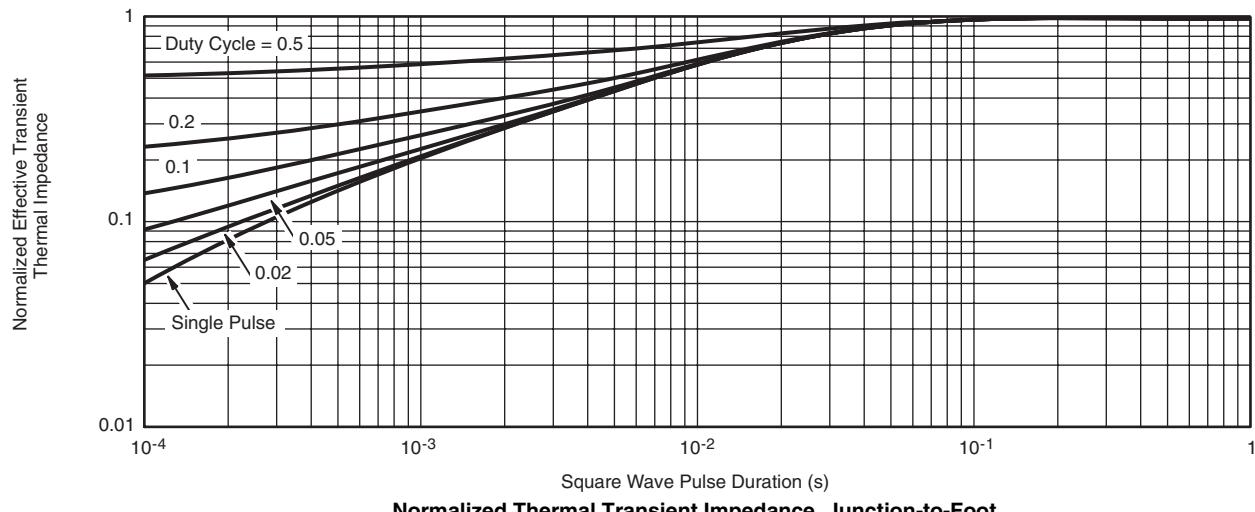
T_C - Case Temperature (°C)

Power Derating

* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**MOSFET TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

Normalized Thermal Transient Impedance, Junction-to-Ambient



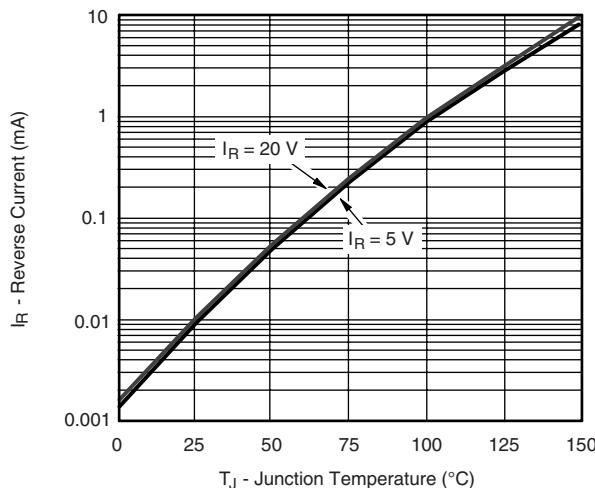
Normalized Thermal Transient Impedance, Junction-to-Foot

Si5853DDC

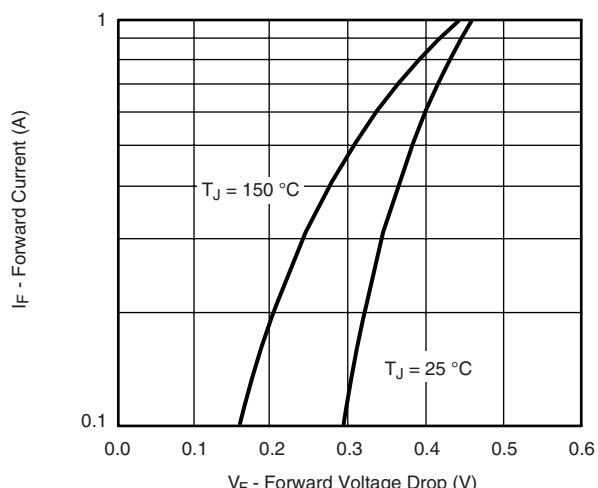
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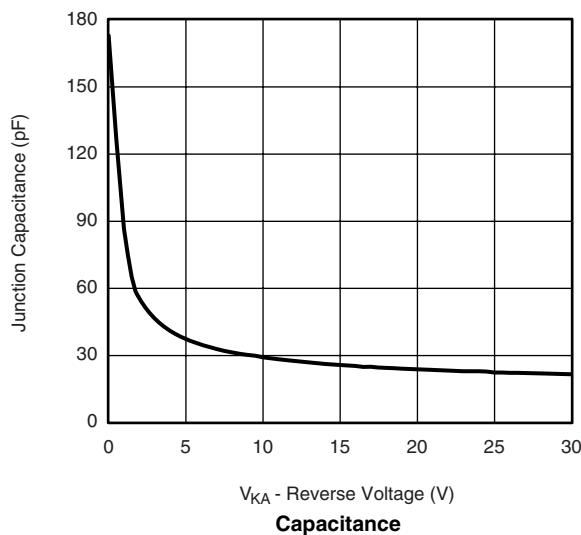
SCHOTTKY TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



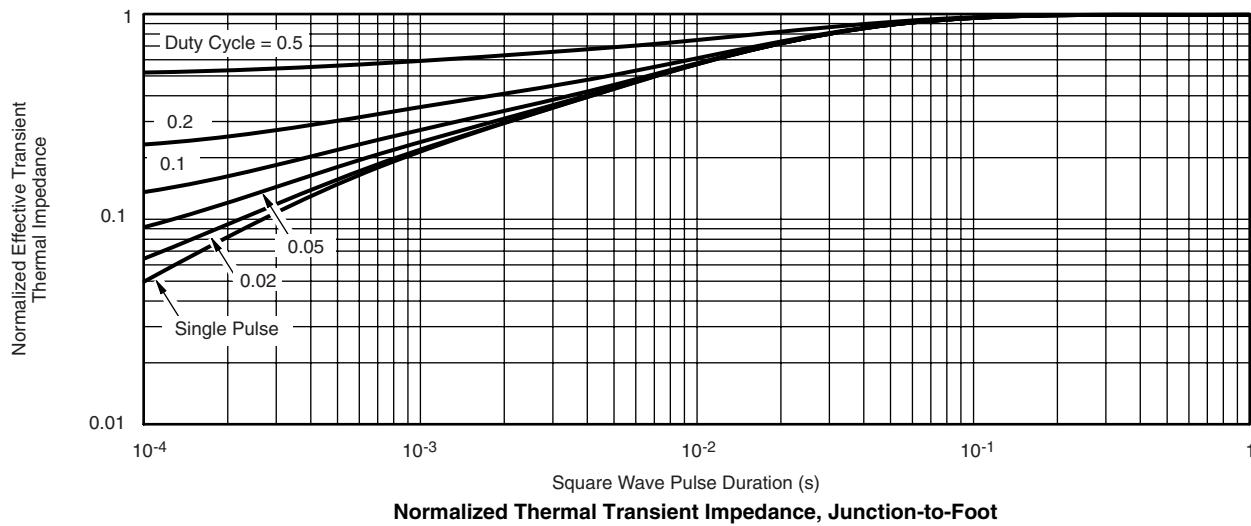
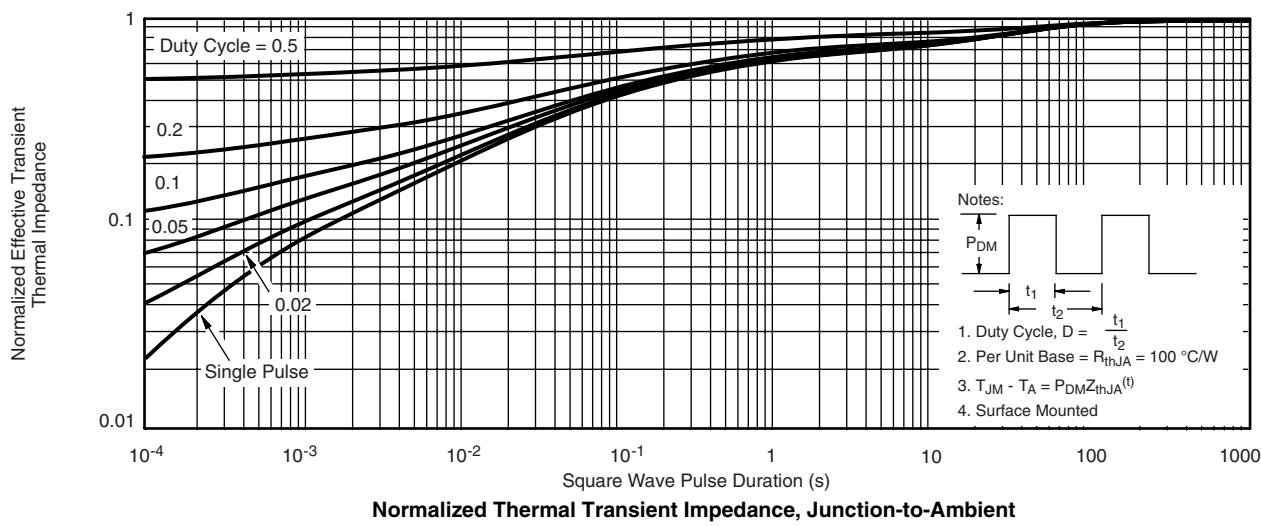
Reverse Current vs. Junction Temperature



Forward Voltage Drop



Capacitance

**SCHOTTKY TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <http://www.vishay.com/ppg?68979>.



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